imall

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Dual N-Channel Power MOSFET

30 V, High Side 18 A / Low Side 27 A, Dual N-Channel SO8FL

Features

- Co-Packaged Power Stage Solution to Minimize Board Space
- Minimized Parasitic Inductances
- Optimized Devices to Reduce Power Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

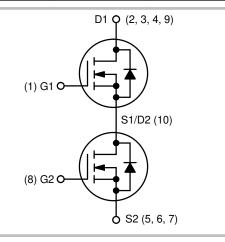
- DC–DC Converters
- System Voltage Rails
- Point of Load

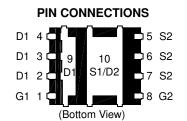


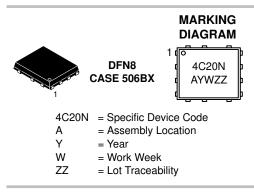
ON Semiconductor®

www.onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
Q1 Top FET	7.3 mΩ @ 10 V	10 4
30 V	10.8 mΩ @ 4.5 V	18 A
Q2 Bottom	3.4 mΩ @ 10 V	27 A
FET 30 V	5.2 mΩ @ 4.5 V	27 A







ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise stated)

Parameter		Symbol	Value	Unit		
Drain-to-Source Voltage	Q1	V _{DSS}	30	V		
Drain-to-Source Voltage	Q2					
Gate-to-Source Voltage			Q1	V _{GS}	±20	V
Gate-to-Source Voltage			Q2			
Continuous Drain Current $R_{\theta JA}$ (Note 1)		T _A = 25°C	Q1	I _D	12	
		T _A = 85°C			8.6	
		T _A = 25°C	Q2		18	A
		T _A = 85°C			13	
Power Dissipation		T _A = 25°C	Q1	P _D	1.88	W
R0JA (Note 1)			Q2		1.97	
Continuous Drain Current $R_{\theta JA} \le 10$ s (Note 1)		T _A = 25°C	Q1	Ι _D	18.2	
		T _A = 85°C			13.1	
	Steady	T _A = 25°C	Q2		27.4	A
	State	T _A = 85°C			19.8	
Power Dissipation		T _A = 25°C	Q1	P _D	4.37	W
$R_{\theta JA} \leq 10 \text{ s} (\text{Note } 1)$			Q2		4.6	
Continuous Drain Current		T _A = 25°C	Q1	Ι _D	9.1	
R _{0JA} (Note 2)		$T_A = 85^{\circ}C$			6.6	
		T _A = 25°C	Q2		13.7	A
		$T_A = 85^{\circ}C$			9.9	
Power Dissipation		T _A = 25 °C	Q1	PD	1.09	W
R _{0JA} (Note 2)			Q2		1.15	
Pulsed Drain Current		TA = 25°C	Q1	I _{DM}	55	Α
		tp = 10 μs	Q2		82	
Operating Junction and Storage Temperature			Q1	T _J , T _{STG}	-55 to +150	°C
			Q2			
Source Current (Body Diode)				ا _S	4.0	Α
	Q2		4.2			
Drain to Source DV/DT		dV/dt	6	V/ns		
Single Pulse Drain-to-Source Avalanche Energy (T	Q1	EAS	16	mJ		
= 50 V, V_{GS} = 10 V, L = 0.1 mH, R_{G} = 25 Ω)	Q2	EAS	42			
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		ΤL	260	°C		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
Surface-mounted on FR4 board using 1 sq-in pad, 2 oz Cu.
Surface-mounted on FR4 board using the minimum recommended pad size of 100 mm².

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	FET	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 3)	Q1	R_{\thetaJA}	66.5	
	Q2		63.3	
Junction-to-Ambient - Steady State (Note 4)	Q1	R_{\thetaJA}	114.3	
	Q2	1	108.7	00.000
Junction-to-Ambient – (t \leq 10 s) (Note 3)	Q1	R_{\thetaJA}	28.6	°C/W
	Q2	1	27.2	
Junction-to-Case - (Drain)	Q1	$R_{ extsf{ heta}JC}$	5.4	
	Q2	1	3.7	

Surface-mounted on FR4 board using 1 sq-in pad, 2 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size of 100 mm².

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	FET	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS								
Drain-to-Source Breakdown	Q1	V _{(BR)DSS}	$V_{GS} = 0 V, I_D$	= 250 μA	30			V
Voltage	Q2		V _{GS} = 0 V, I	_D = 1 mA	30			
Drain-to-Source Breakdown	Q1	V _{(BR)DSS} / T _J				14.5		mV/°C
Voltage Temperature Coefficient	Q2	۱J				12		
Zero Gate Voltage Drain Cur-	Q1	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	$T_J = 25^{\circ}C$			1	μΑ
rent			$V_{DS} = 24 V$	T _J = 125°C			10	
	Q2		V _{GS} = 0 V, V _{DS} = 24 V	T _J = 25°C			10	
Gate-to-Source Leakage Cur-	Q1	I _{GSS}	$V_{DS} = 0 V, V_{C}$	_{as} = ±20 V			±100	nA
rent	Q2						±100	
ON CHARACTERISTICS (Note 5))					-		-
Gate Threshold Voltage	Q1	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{DS}$	₀ = 250 μA	1.3		2.1	V
	Q2				1.3		2.1	
Negative Threshold Temper-	Q1	V _{GS(TH)} / T _J				4.7		mV/°C
ature Coefficient	Q2	IJ				5.1		1
Drain-to-Source On Resist-	Q1	R _{DS(on)}	V _{GS} = 10 V	I _D = 10 A		5.8	7.3	

Drain-to-Source On Resist-	Q1	R _{DS(on)}	V _{GS} = 10 V	I _D = 10 A	5.8	7.3	
ance			V _{GS} = 4.5 V	I _D = 10 A	8.7	10.8	m O
	Q2		V _{GS} = 10 V	I _D = 20 A	2.7	3.4	mΩ
			V _{GS} = 4.5 V	I _D = 20 A	4.0	5.2	
Forward Transconductance	Q1	9fs	V _{DS} = 1.5 V, I _D = 10 A		43		S
	Q2				68		

5. Pulse Test: pulse width \leq 300 µs, duty cycle \leq 2%. 6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	FET	Symbol	Test Condition	Min	Тур	Мах	Unit	
CHARGES, CAPACITANCES & GATE RESISTANCE								
Innut Consolitores	Q1	0			970			
Input Capacitance	Q2	C _{ISS}			1950			
	Q1	0			430			
Output Capacitance	Q2	C _{OSS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V		990		pF	
Devery Orace iterate	Q1	_			125			
Reverse Capacitance	Q2	C _{RSS}			50			
Tabal Qada Qhanna	Q1	~			9.3			
Total Gate Charge	Q2	Q _{G(TOT)}			13			
	Q1				1.6			
Threshold Gate Charge	Q2	Q _{G(TH)}			3.3			
	Q1		$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_{D} = 10 \text{ A}$		3.3		nC	
Gate-to-Source Charge	Q2	Q _{GS}			6.0		1	
	Q1				4.2		1	
Gate-to-Drain Charge	Q2	Q _{GD}			3.0		1	
	Q1			19		1		
Total Gate Charge	Q2	Q _{G(TOT)}	$V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 10 \text{ A}$		29		nC	
SWITCHING CHARACTERISTIC	S (Note 6	6)						
	Q1		V_{GS} = 4.5 V, V_{DS} = 15 V, I _D = 15 A, R _G = 3.0 Ω		9.0			
Turn-On Delay Time	Q2	t _{d(ON)}			11			
	Q1				33			
Rise Time	Q2	t _r			32			
	Q1				15		ns	
Turn-Off Delay Time	Q2	t _{d(OFF)}			20		1	
	Q1				5.0			
Fall Time	Q2	t _f			5.0			
SWITCHING CHARACTERISTIC	CS (Note 6	6)						
T O D I T	Q1				6.0			
Turn-On Delay Time	Q2	t _{d(ON)}			8.0			
	Q1	t _r			26			
Rise Time	Q2		$V_{00} = 10 \text{ V}$ $V_{00} = 15 \text{ V}$		26			
	Q1		V_{GS} = 10 V, V_{DS} = 15 V, I _D = 15 A, R _G = 3.0 Ω		18		ns	
Turn-Off Delay Time	Q2	t _{d(OFF)}			25			
	Q1		1		4.0		-	
Fall Time	Q2	t _f			4.0		1	
DRAIN-SOURCE DIODE CHARACTERISTICS								
			$V_{CS} = 0 V_{.}$ $T_{J} = 25^{\circ}C$		0.75	1.0		

Forward Voltage	Q1		$V_{GS} = 0 V,$ $I_{S} = 3 A$	$T_J = 25^{\circ}C$	0.75	1.0	
		N		$T_J = 125^{\circ}C$	0.62		
	Q2	VSD	V _{GS} = 0 V,	$T_J = 25^{\circ}C$	0.45	0.70	v
		I _S = 3 A	T,₁ = 125°C	0.37			

5. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%. 6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	FET	Symbol	Test Condition	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARA	DRAIN-SOURCE DIODE CHARACTERISTICS						
Roverse Resevent Time	Q1	÷			23		
Reverse Recovery Time	Q2	t _{RR}			38		
Charge Time	Q1	ta	V _{GS} = 0 V, d _{IS} /d _t = 100 A/μs, I _S = 30 A		11.6		20
Charge Time	Q2				18.6		ns
Disabaras Tima	Q1	th			11.4		
Discharge Time	Q2	tb			19.4		
Deverse Desevery Charge	Q1	0			10		20
Reverse Recovery Charge	Q2	Q _{RR}			25		nC

PACKAGE PARASITIC VALUES

	Q1	1			0.38		
Source Inductance	Q2	LS			0.65		nH
Droin Industance	Q1	1			0.054		
Drain Inductance	Q2	LD			0.007		nH
Cata Industance	Q1	1	$T_A = 25^{\circ}C$		1.5		
Gate Inductance	Q2	L _G			1.5		nH
Gate Resistance	Q1	Р		0.3	1.0	2.0	0
Gale Resistance	Q2	R _G		0.3	1.0	2.0	Ω

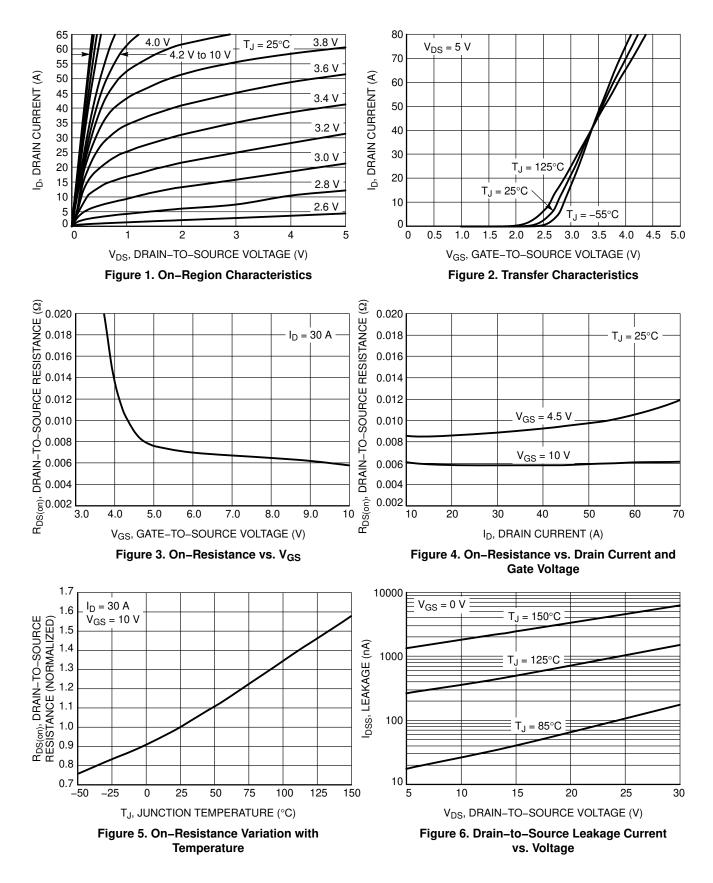
5. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

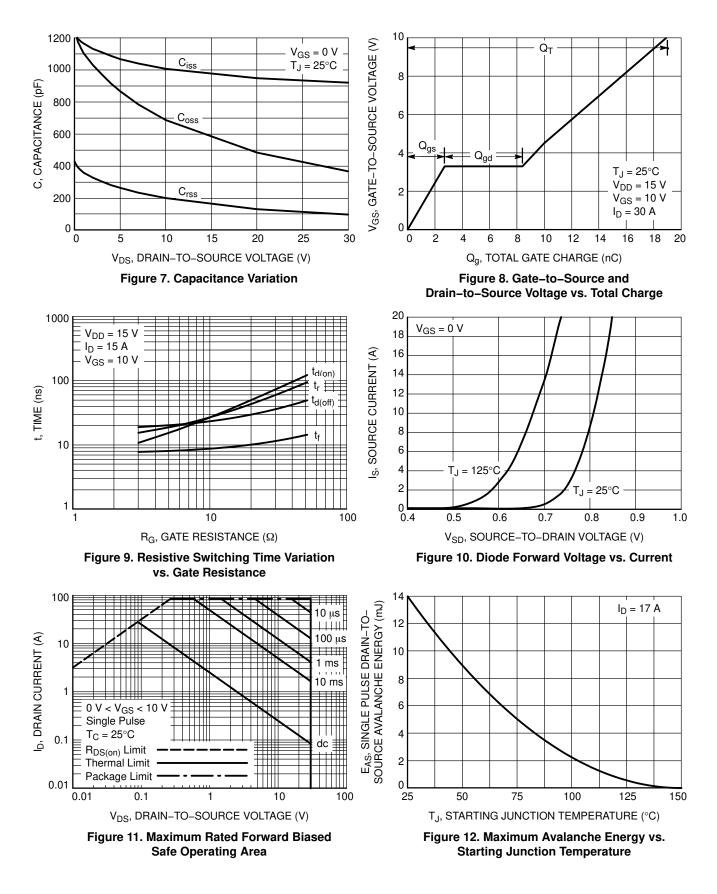
6. Switching characteristics are independent of operating junction temperatures.

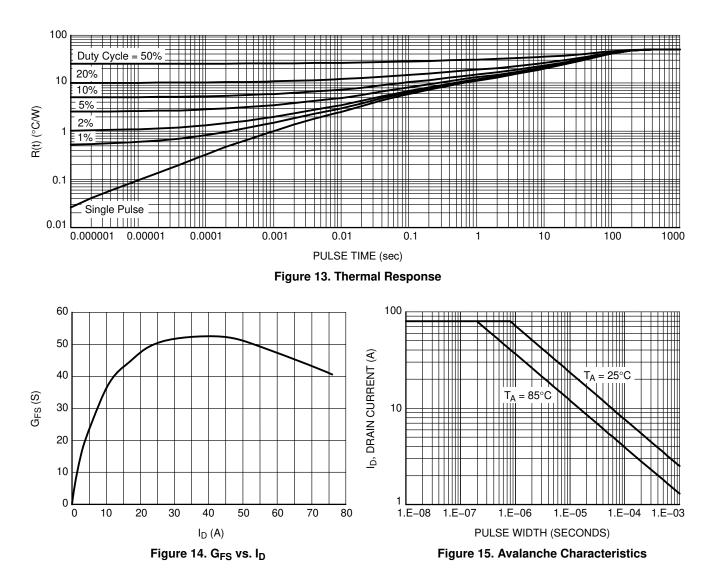
ORDERING INFORMATION

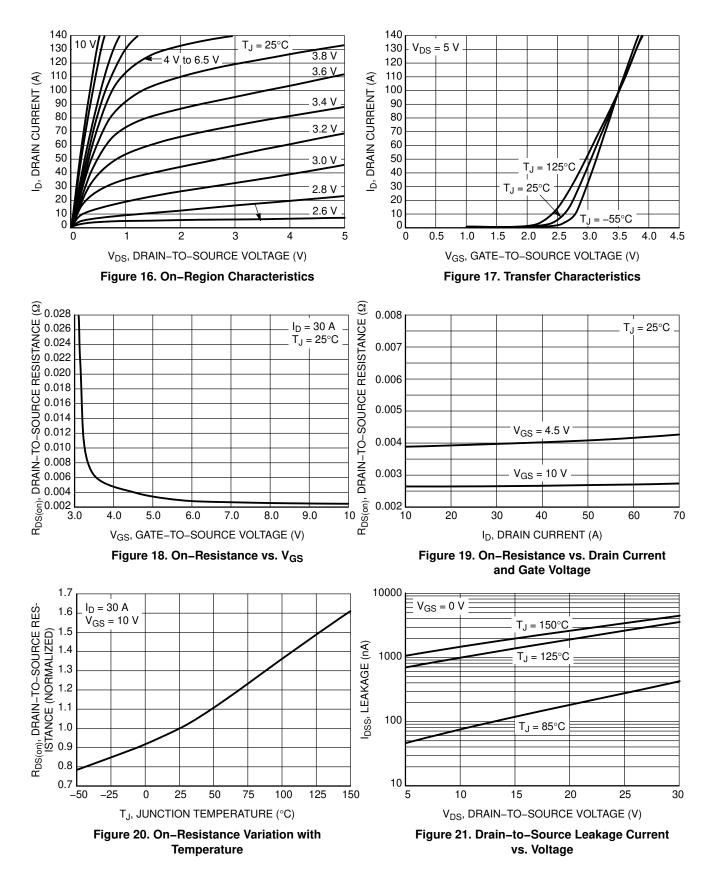
Device	Package	Shipping [†]
NTMFD4C20NT1G	DFN8 (Pb–Free)	1500 / Tape & Reel

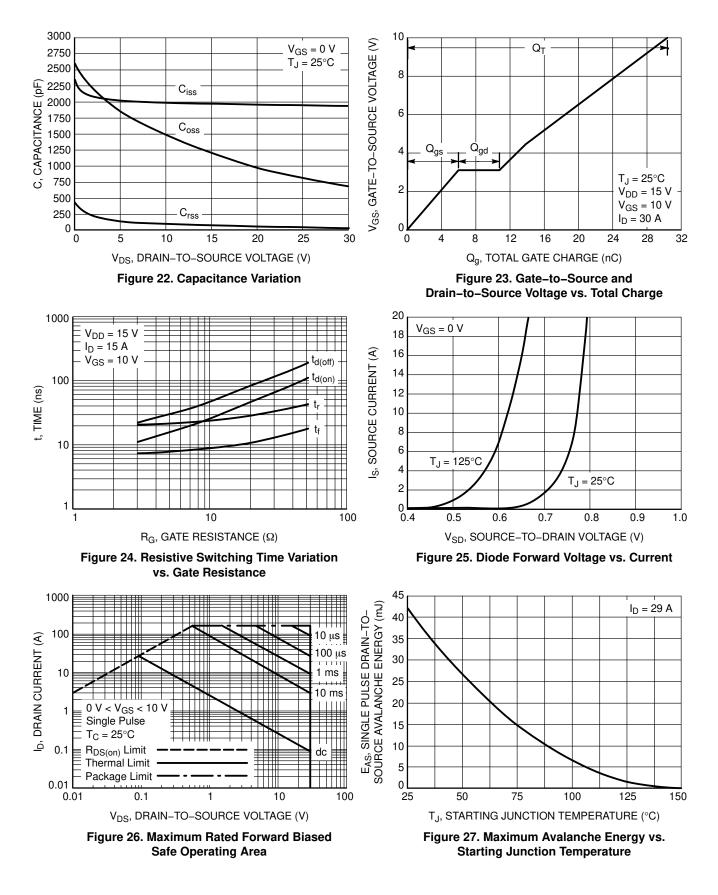
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

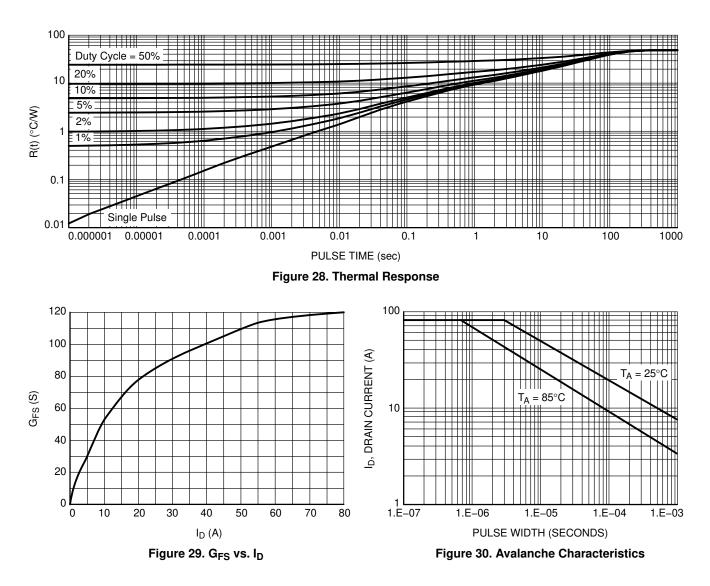




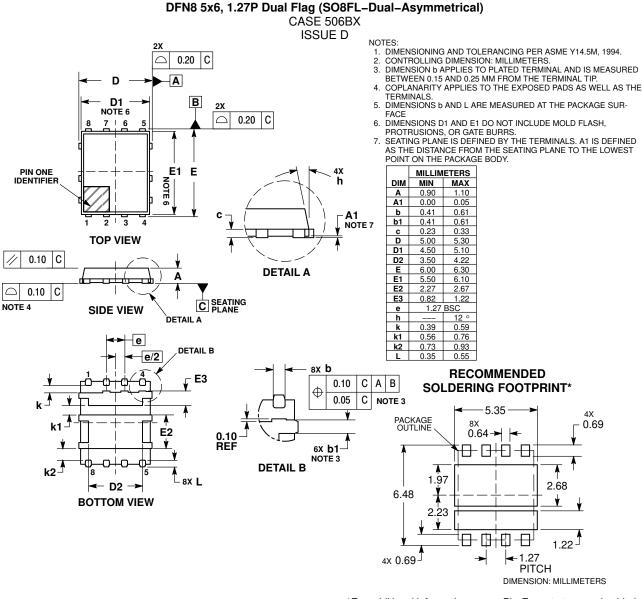








PACKAGE DIMENSIONS



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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